## N-channel 650 V, $0.09 \Omega$ typ., 28 A MDmesh ${ }^{\text {M }}$ V Power MOSFETs in TO-220FP, I ${ }^{2}$ PAKFP, I $I^{2}$ PAK packages <br> Datasheet - production data



Figure 1. Internal schematic diagram


## Features

| Order codes | $\mathbf{V}_{\mathbf{D S}} @ \mathbf{T}_{\text {Jmax }}$ | $\mathbf{R}_{\mathbf{D S} \text { (on) }}$ max | $\mathbf{I}_{\mathbf{D}}$ |
| :---: | :---: | :---: | :---: |
| STF34N65M5 | 710 V | $0.11 \Omega$ | 28 A |
| STFI34N65M5 |  |  |  |

- Worldwide best $\mathrm{R}_{\mathrm{DS}(\mathrm{on})}$ * area
- Higher $\mathrm{V}_{\text {DSS }}$ rating and high dv/dt capability
- Excellent switching performance
- $100 \%$ avalanche tested


## Applications

- Switching applications


## Description

These devices are N -channel MDmesh ${ }^{\text {™ }} \mathrm{V}$ Power MOSFETs based on an innovative proprietary vertical process technology, which is combined with STMicroelectronics' well-known PowerMESH ${ }^{\text {TM }}$ horizontal layout structure. The resulting product has extremely low onresistance, which is unmatched among siliconbased Power MOSFETs, making it especially suitable for applications which require superior power density and outstanding efficiency.

Table 1. Device summary

| Order codes | Marking | Packages | Packaging |
| :---: | :---: | :---: | :---: |
| STF34N65M5 | $34 N 65 M 5$ | TO-220FP | Tube |
| STFI34N65M5 |  | $I^{2}$ PAKFP (TO-281) |  |

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## Electrical ratings

Table 2. Absolute maximum ratings

| Symbol | Parameter | Value | Unit |
| :---: | :--- | :---: | :---: |
| $\mathrm{V}_{\mathrm{GS}}$ | Gate-source voltage | $\pm 25$ | V |
| $\mathrm{I}_{\mathrm{D}}$ | Drain current (continuous) at $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | $28^{(1)}$ | A |
| $\mathrm{I}_{\mathrm{D}}$ | Drain current (continuous) at $\mathrm{T}_{\mathrm{C}}=100^{\circ} \mathrm{C}$ | $17.7^{(1)}$ | A |
| $\mathrm{I}_{\mathrm{DM}}{ }^{(1)}$ | Drain current (pulsed) | $112^{(1)}$ | A |
| $\mathrm{P}_{\mathrm{TOT}}$ | Total dissipation at $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | 35 | W |
| dv/dt ${ }^{(2)}$ | Peak diode recovery voltage slope | 15 | $\mathrm{~V} / \mathrm{ns}$ |
| dv/dt ${ }^{(3)}$ | MOSFET dv/dt ruggedness | 50 | $\mathrm{~V} / \mathrm{ns}$ |
| $\mathrm{V}_{\text {ISO }}$ | Insulation withstand voltage $(\mathrm{RMS})$ from all <br> three leads to external heat sink <br> $\left(\mathrm{t}=1 \mathrm{~s} ; ~ \mathrm{TC}=25^{\circ} \mathrm{C}\right)$ | 2500 | V |
| $\mathrm{~T}_{\text {stg }}$ | Storage temperature | -55 to 150 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\mathrm{j}}$ | Max. operating junction temperature | 150 | ${ }^{\circ} \mathrm{C}$ |

1. Limited by maximum junction temperature.
2. $\mathrm{I}_{\mathrm{SD}} \leq 28 \mathrm{~A}, \mathrm{di} / \mathrm{dt} \leq 400 \mathrm{~A} / \mu \mathrm{s} ; \mathrm{V}_{\mathrm{DS} \text { peak }}<\mathrm{V}_{(\mathrm{BR}) \mathrm{DSS}}, \mathrm{V}_{\mathrm{DD}}=400 \mathrm{~V}$.
3. $\mathrm{V}_{\mathrm{DS}} \leq 480 \mathrm{~V}$

Table 3. Thermal data

| Symbol | Parameter | Value | Unit |
| :---: | :--- | :---: | :---: |
| $\mathrm{R}_{\text {thj-case }}$ | Thermal resistance junction-case max | 3.57 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\mathrm{R}_{\text {thj-amb }}$ | Thermal resistance junction-ambient max | 62.5 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |

Table 4. Avalanche characteristics

| Symbol | Parameter | Value | Unit |
| :---: | :--- | :---: | :---: |
| $\mathrm{I}_{\mathrm{AR}}$ | Avalanche current, repetitive or not repetitive <br> (pulse width limited by $\mathrm{T}_{\text {jmax }}$ ) | 7 | A |
| $\mathrm{E}_{\mathrm{AS}}$ | Single pulse avalanche energy (starting $\mathrm{t}_{\mathrm{j}}=25^{\circ} \mathrm{C}$, <br> $\mathrm{I}_{\mathrm{d}}=\mathrm{I}_{\mathrm{AR}} ; \mathrm{V}_{\mathrm{dd}}=50$ ) | 510 | mJ |

## 2 Electrical characteristics

( $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ unless otherwise specified)

Table 5. On /off states

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
| :---: | :--- | :--- | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{(\mathrm{BR}) \mathrm{DSS}}$ | Drain-source <br> breakdown voltage | $\mathrm{I}_{\mathrm{D}}=1 \mathrm{~mA}, \mathrm{~V}_{\mathrm{GS}}=0$ | 650 |  |  | V |
| $\mathrm{I}_{\mathrm{DSS}}$ | Zero gate voltage <br> drain current $\left(\mathrm{V}_{\mathrm{GS}}=0\right)$ | $\mathrm{V}_{\mathrm{DS}}=650 \mathrm{~V}$ <br> $\mathrm{~V}_{\mathrm{DS}}=650 \mathrm{~V}, \mathrm{~T}_{\mathrm{C}}=125^{\circ} \mathrm{C}$ |  |  | 1 | $\mu \mathrm{~A}$ |
| 100 | $\mu \mathrm{~A}$ |  |  |  |  |  |$|$

Table 6. Dynamic

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{C}_{\text {iss }}$ | Input capacitance | $\begin{aligned} & \mathrm{V}_{\mathrm{DS}}=100 \mathrm{~V}, \mathrm{f}=1 \mathrm{MHz}, \\ & \mathrm{~V}_{\mathrm{GS}}=0 \end{aligned}$ | - | 2700 | - | pF |
| $\mathrm{C}_{\text {oss }}$ | Output capacitance |  | - | 75 | - | pF |
| Crss | Reverse transfer capacitance |  | - | 6.3 | - | pF |
| $\mathrm{C}_{\mathrm{o}(\mathrm{tr})^{(1)}}$ | Equivalent capacitance time related | $\mathrm{V}_{\mathrm{DS}}=0$ to $520 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0$ | - | 220 | - | pF |
| $\mathrm{C}_{\mathrm{o}(\mathrm{er})}{ }^{(2)}$ | Equivalent capacitance energy related |  | - | 63 | - | pF |
| $\mathrm{R}_{\mathrm{G}}$ | Intrinsic gate resistance | $\mathrm{f}=1 \mathrm{MHz}$ open drain | - | 1.95 | - | $\Omega$ |
| $\mathrm{Q}_{\mathrm{g}}$ | Total gate charge | $\begin{aligned} & \mathrm{V}_{\mathrm{DD}}=520 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=14 \mathrm{~A}, \\ & \mathrm{~V}_{\mathrm{GS}}=10 \mathrm{~V} \\ & \text { (see Figure 16) } \end{aligned}$ | - | 62.5 | - | nC |
| $\mathrm{Q}_{\mathrm{gs}}$ | Gate-source charge |  | - | 17 | - | nC |
| $Q_{\text {gd }}$ | Gate-drain charge |  | - | 28 | - | nC |

1. Time related is defined as a constant equivalent capacitance giving the same charging time as $\mathrm{C}_{\text {oss }}$ when $V_{D S}$ increases from 0 to $80 \% V_{D S S}$
2. Energy related is defined as a constant equivalent capacitance giving the same stored energy as $\mathrm{C}_{\text {oss }}$ when $\mathrm{V}_{\mathrm{DS}}$ increases from 0 to $80 \% \mathrm{~V}_{\mathrm{DSS}}$

Table 7. Switching times

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $t_{d}(\mathrm{v})$ | Voltage delay time | $\begin{aligned} & \mathrm{V}_{\mathrm{DD}}=400 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=18 \mathrm{~A}, \\ & \mathrm{R}_{\mathrm{G}}=4.7 \Omega, \mathrm{~V}_{\mathrm{GS}}=10 \mathrm{~V} \end{aligned}$ <br> (see Figure 17 and Figure 20) | - | 59 | - | ns |
| $\mathrm{tr}_{\mathrm{r}}(\mathrm{v})$ | Voltage rise time |  | - | 8.7 | - | ns |
| $\mathrm{t}_{\mathrm{f}}(\mathrm{i})$ | Current fall time |  | - | 7.5 | - | ns |
| $\mathrm{t}_{\mathrm{c}}$ (off) | Crossing time |  | - | 12 | - | ns |

Table 8. Source drain diode

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{I}_{\text {SD }}$ | Source-drain current |  | - |  | 28 | A |
| $\mathrm{I}_{\text {SDM }}{ }^{(1)}$ | Source-drain current (pulsed) |  | - |  | 112 | A |
| $\mathrm{V}_{S D}{ }^{(2)}$ | Forward on voltage | $\mathrm{I}_{\mathrm{SD}}=28 \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}=0$ | - |  | 1.5 | V |
| $\mathrm{t}_{\mathrm{rr}}$ | Reverse recovery time | $\begin{aligned} & \mathrm{I}_{\mathrm{SD}}=28 \mathrm{~A}, \mathrm{di} / \mathrm{dt}=100 \mathrm{~A} / \mu \mathrm{s} \\ & \mathrm{~V}_{\mathrm{DD}}=100 \mathrm{~V}(\text { see Figure } 20) \end{aligned}$ | - | 350 |  | ns |
| $Q_{\text {rr }}$ | Reverse recovery charge |  | - | 5.6 |  | $\mu \mathrm{C}$ |
| $\mathrm{I}_{\text {RRM }}$ | Reverse recovery current |  | - | 32 |  | A |
| $\mathrm{t}_{\mathrm{rr}}$ | Reverse recovery time | $\begin{aligned} & \mathrm{I}_{\mathrm{SD}}=28 \mathrm{~A}, \mathrm{di} / \mathrm{dt}=100 \mathrm{~A} / \mu \mathrm{s} \\ & \mathrm{~V}_{\mathrm{DD}}=100 \mathrm{~V}, \mathrm{~T}_{\mathrm{j}}=150^{\circ} \mathrm{C} \\ & \text { (see Figure 20) } \end{aligned}$ | - | 422 |  | ns |
| $\mathrm{Q}_{\mathrm{rr}}$ | Reverse recovery charge |  | - | 7.4 |  | $\mu \mathrm{C}$ |
| $\mathrm{I}_{\text {RRM }}$ | Reverse recovery current |  | - | 35 |  | A |

1. Pulse width limited by safe operating area.
2. Pulsed: pulse duration $=300 \mu \mathrm{~s}$, duty cycle $1.5 \%$

### 2.1 Electrical characteristics (curves)

Figure 2. Safe operating area


Figure 3. Thermal impedance


Figure 5. Transfer characteristics


Figure 6. Gate charge vs gate-source voltage

| VGS <br> (V) $12$ | $\square$ |  |  | AM15321v1 |
| :---: | :---: | :---: | :---: | :---: |
|  |  | VDD=520 V |  |  |
|  |  |  |  |  |
|  |  |  |  |  |
|  | VDs | $\mathrm{ld}=14 \mathrm{~A}$ |  |  |
|  |  |  |  |  |
| 10 |  |  | - | 400 |
| 8 |  |  |  |  |
|  |  |  |  | 300 |
|  | 5 |  |  |  |
| 64 |  |  |  |  |
|  |  |  |  | 200 |
| 2 |  |  |  |  |
|  | 1 |  |  | 100 |
| 2 | - |  |  |  |
|  |  | V |  |  |
|  | 20 | 4050 | $30 \quad 70 \quad 80$ | ${ }_{0}(\mathrm{nC})$ |

Figure 7. Static drain-source on-resistance


Figure 8. Capacitance variations


Figure 10. Normalized gate threshold voltage vs temperature


Figure 12. Source-drain diode forward characteristics


Figure 14. Switching losses vs gate resistance (1)


1. Eon including reverse recovery of a SiC diode

## 3 Test circuits

Figure 15. Switching times test circuit for resistive load


Figure 17. Test circuit for inductive load switching and diode recovery times

Figure 16. Gate charge test circuit


Figure 18. Unclamped inductive load test circuit


Figure 19. Unclamped inductive waveform


Figure 20. Switching time waveform


## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK ${ }^{\circledR}$ packages, depending on their level of environmental compliance. ECOPACK ${ }^{\circledR}$ specifications, grade definitions and product status are available at: www.st.com. ECOPACK ${ }^{\circledR}$ is an ST trademark.

Figure 21. TO-220FP drawing


Table 9. TO-220FP mechanical data

| Dim. | mm |  |  |
| :---: | :---: | :---: | :---: |
|  | Min. | Typ. | Max. |
| A | 4.4 |  | 4.6 |
| B | 2.5 |  | 2.7 |
| D | 2.5 |  | 2.75 |
| E | 0.45 |  | 0.7 |
| F | 0.75 |  | 1 |
| F1 | 1.15 |  | 1.70 |
| F2 | 1.15 |  | 1.70 |
| G | 4.95 |  | 5.2 |
| G1 | 2.4 |  | 2.7 |
| H | 10 |  | 10.4 |
| L2 | 28.6 |  | 30.6 |
| L3 | 9.8 |  | 10.6 |
| L4 | 2.9 |  | 3.6 |
| L5 | 15.9 |  | 16.4 |
| L6 | 9 |  | 9.3 |
| L7 | 3 |  | 3.2 |
| Dia |  |  |  |

Figure 22. $I^{2}$ PAKFP (TO-281) drawing


Table 10. $1^{2}$ PAKFP (TO-281) mechanical data

| Dim. | mm |  |  |
| :---: | :---: | :---: | :---: |
|  | Min. | Typ. | Max. |
| A | 4.40 |  | 4.60 |
| B | 2.50 |  | 2.70 |
| D | 2.50 |  | 2.75 |
| D1 | 0.65 |  | 0.85 |
| E | 0.45 |  | 0.70 |
| F | 0.75 |  | 1.00 |
| F1 |  |  | 1.20 |
| G | 4.95 | - | 5.20 |
| H | 10.00 |  | 10.40 |
| L1 | 21.00 |  | 23.00 |
| L2 | 13.20 |  | 14.10 |
| L3 | 10.55 |  | 10.85 |
| L4 | 2.70 |  | 3.20 |
| L5 | 0.85 |  | 1.25 |
| L6 | 7.30 |  | 7.50 |

## 5 Revision history

Table 11. Document revision history

| Date | Revision | Changes |
| :---: | :---: | :--- |
| 14-Jan-2014 | 1 | First release. Part numbers previously included in datasheet <br> DocID022853 |

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